

## **Anchoring Subnanometric Cu<sub>4</sub> Clusters in Graphitic-C<sub>3</sub>N<sub>5</sub> for Highly Efficient CO<sub>2</sub> Photoreduction to Ethanol**

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## Materials and Methods

**Chemical reagents.** Melamine (99%), hydrazine hydrate (55%), HCl (37%), copper dinitrate ( $\text{Cu}(\text{NO}_3)_2$ ), ethanol ( $\text{C}_2\text{H}_5\text{OH}$ ), Nafion solution (5wt%), potassium hydroxide (KOH), Sodium sulfate anhydrous ( $\text{Na}_2\text{SO}_4$ ), potassium nitrate ( $\text{KNO}_3$ ), and ethanol (99.8%) were obtained from Shanghai Macklin Biochemical Technology Co., Ltd. All chemicals were used without any additional purification. The water used in all experiments with a resistivity of  $18.2 \text{ M}\Omega$  was prepared using an ultrapure water system.

**Characterizations.** The phase structures of as-prepared samples were identified by the Rigaku B/Max-RB X-ray diffractometer. The morphologies and microstructures of the prepared samples were observed by field emission transmission electron microscopy (TEM, JEOL JEM-2100F) and high-resolution TEM (HRTEM) operated at 200 kV. The surface electronic states and element composition were determined by X-ray photoelectron spectroscopy (XPS, ESCALAB 250Xi). UV-vis diffuse reflectance spectra were tested on a UV-2550 (Shimadzu) spectrophotometer. The FTIR spectra were recorded as a function of time to investigate the dynamics of the conversion of the reactants under irradiation. The desorption performances of  $\text{CO}_2$  were characterized by a temperature programmed chemical adsorption instrument (TPD, Chemisorb 2720; Micromeritics). Photoluminescence spectra (PL) and transient absorption spectra (TAS) were recorded on an Edinburgh LP 980 spectrofluorimeter. The element molar ratios were obtained by inductively coupled plasma mass spectrometer (ICP-MS, NexION 300X). In situ DRIFTS measurements were performed on Bruker VERTEX 70 infrared instrument equipped with a tailor-made reactor and a 300 W Xenon lamp. Typically, the loaded samples were evenly placed in the bottom of the analyzed chamber and sealed. Subsequently, a mixed atmosphere ( $\text{CO}_2$  with a trace of  $\text{H}_2\text{O}$  vapor) was introduced into the reactor for 20 min at room temperature. After reaching the sorption equilibrium, the DRIFTS spectra were acquired by the dynamics of the transition of the reactants under illumination. The Quasi in-situ X-ray photoelectron spectroscopy (QIS-XPS) instrument was equipped with a 300 W Xe lamp as light source. Before QIS-XPS measurements, after being made into thin sheets with suitable size, the photocatalyst was placed in a sealed adsorption chamber and purged with Ar ( $50 \text{ mL min}^{-1}$ ) at  $120^\circ\text{C}$  for 30 min to remove the surface adsorbed impurities. Subsequently, a  $\text{CO}_2/\text{H}_2\text{O}$  (vapor) mixed gas with 80:20 volume ratio was purged into

the chamber at room temperature for 20 min to reach the adsorption equilibrium. Finally, the as-prepared samples were quickly transferred to the analysis chamber of XPS instrument (ESCALAB 250Xi) for the QIS-XPS measurements. The variations of XPS spectra were recorded by controlling light irradiation (on or off). X-ray adsorption near edge structure (XANES) measurements were measured at Shanghai Synchrotron Radiation Facility in China. The output beam was selected by Si(111) monochromator. The data were collected at room temperature under fluorescence mode by using solid state detector.

**Preparation of  $C_3N_5$ .** The bulk  $C_3N_5$  was prepared following the previous report.<sup>1</sup>

**Preparation of  $Cu/C_3N_5$ .** The melem hydrazine powder was prepared following the previous report.<sup>1</sup> 340 mg  $Cu(NO_3)_2 \cdot 3H_2O$  was firstly dissolved in ethanol by stirring at 50°C, and then 3 g melem hydrazine powder was added into the above solution with sonication for 30 min to gain a well-dispersed suspension. The suspension was kept on stirring for 12 h and then separated by filtration with ethanol and finally dried at 60°C. The obtained product was further pyrolyzed at 450°C with the ramping rate of 5°C min<sup>-1</sup> under N<sub>2</sub> atmosphere. Finally, the obtained powder was immersed in 0.5 M H<sub>2</sub>SO<sub>4</sub> at 80°C for 12 h to remove the possible metallic Cu species.

**Synthesis of  $Cu_4/C_3N_5$ .** The entire preparation process was carried out in a glove box to avoid the influence of O<sub>2</sub>. The  $Cu_4/C_3N_5$  was constructed *via* electrochemical method in a CHI 660E electrochemical workstation equipped with a sealed H-type cell segregated by nafion-117 proton exchange membrane. Ag/AgCl equipped with salt bridge and platinum foil (5\*5 cm<sup>2</sup>) were used as the reference and counter electrodes, respectively. The working electrode was prepared as following: 20 mg  $Cu/C_3N_5$  powder was dispersed in 100 uL 5wt% Nafion and 200 uL ethanol, and then sonicated the mixture for 30 min. The well-dispersed catalyst ink was uniformly brushed on GDL substrate with an area of 2\*10 cm<sup>2</sup>, and dried at 50°C. For the electrochemical synthesis, Ar-saturated 50 mL 0.1 M KOH including 0.1 M KNO<sub>3</sub> was used as electrolytes. Cyclic voltammograms (CVs) was performed. The electrocatalytic synthesis were conducted at different potentials (-0.20, -0.40, -0.60, -0.80, and -1.00 V vs. RHE) for 30 min by chronoamperometric tests. The catalyst powders were collected by gently scraping the electrode surface and then

immersed into ethanol solution for 12 h to remove the Nafion component. To obtain enough catalyst powders, the above preparation processes were repeated. The as-prepared samples were stored in inert atmosphere.

#### **Photocatalytic CO<sub>2</sub> reduction measurements.**

100 mg of catalyst was added to 20 mL NaHCO<sub>3</sub> aqueous solution (0.1 M), sonicated for 20 min and then transferred into a tailor-made vessel and then hermetically sealed. Before illumination, high-purity CO<sub>2</sub> (99.999%) was continuously purged into the solution for 30 min to produce a mixture of CO<sub>2</sub> and H<sub>2</sub>O vapors to replace the atmosphere in the glass vessel. The reaction temperature of the system was maintained at 25°C by circulating cooling water. A 300 W xenon lamp (Microsolar300, PerfectLight) equipped with a 420 nm cut off filter was employed as the light source. The products were analyzed using Agilent GC 6890N gas chromatograph with a flame ionization detector (FID) and thermal conductivity detector (TCD). The chromatographic columns were di-n-butyl phthalate fill column and polyethylene glycol 20000 fill column.

To investigate the effect of possible existing Nafion residues or other organic residues, a comparative blank photocatalytic evaluation experiment without CO<sub>2</sub> was performed in pure water following the above procedure.

**Isotopic <sup>13</sup>CO<sub>2</sub> experiments.** <sup>13</sup>C-labeled CO<sub>2</sub> (<sup>13</sup>CO<sub>2</sub>, 99.999%) gas was used as the feed gas in the labeling experiment. 50 mg of catalyst was added to 20 mL DMF/H<sub>2</sub>O mixture (12.5 vol% H<sub>2</sub>O), sonicated for 10 min and then transferred into a tailor-made vessel and then hermetically sealed. Before illumination, high-purity Ar was continuously purged into the solution at 300 mL min<sup>-1</sup> for 30 min to remove air and then blown with <sup>13</sup>CO<sub>2</sub> gas was purged into the vessel with the inner pressure at 1.0 MPa. The reactor temperature was kept at 25°C with a cooling water circulator. A 300 W xenon lamp (Microsolar300, PerfectLight) equipped with a 420 nm cut off filter was employed as the light source. The final production was checked by GC-MS (TRACE1310-ISQ-LT). The GC-MS spectrum of <sup>12</sup>C-labeled CO<sub>2</sub> was obtained following the above procedure by replacing <sup>13</sup>CO<sub>2</sub> with <sup>12</sup>CO<sub>2</sub> gas.

**Photoelectrochemical measurements.** All photoelectrochemical measurements were performed

in a three-electrode configuration (CHI 660E, Shanghai, China), in which the sample photoelectrode, Pt sheet and Ag/AgCl electrode were served as the working electrode, counter electrode and reference electrode, respectively. Na<sub>2</sub>SO<sub>4</sub> aqueous solution (0.2 M) was used as electrolyte. To prepare photoelectrodes, as-prepared catalyst (5 mg) was dispersed into the 1 mL mixture solution (0.75 mL H<sub>2</sub>O and 0.25 mL isopropanol) containing 20 μL 5% Nafion under vigorous ultrasonic treatment for 60 min. And then, 50 μL of gel solution was dip-coated on FTO glass and dried at 60°C for 2 h to obtain Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> electrode. A 300 W Xenon lamp was worked as illumination source. Before the photocurrent measurement, the electrolyte solution was saturated with Ar atmosphere for 30 min at room temperature.

**Computational method.** DFT calculations were carried out based on the Cambridge Serial Total Energy Package. The exchange-correlation energy is described by the generalized gradient approximation using the Perdew-Burke-Ernzerh (PBE) of functional. The effect of the van der Waals interactions is considered by using the empirical correction scheme of Grimme's DFT-D method. A 400 eV plane-wave kinetic energy cutoff was chosen. Geometry optimization has been done with the Brillouin zone sampling limited to the gamma point. The atomic positions were fully relaxed until a maximum energy difference and residual force on atoms, respectively, converged to 10<sup>-5</sup> eV and 0.03 eV Å<sup>-1</sup>. A 15 Å vacuum layer was added to prevent the interaction.

## Additional Figures and Discussions

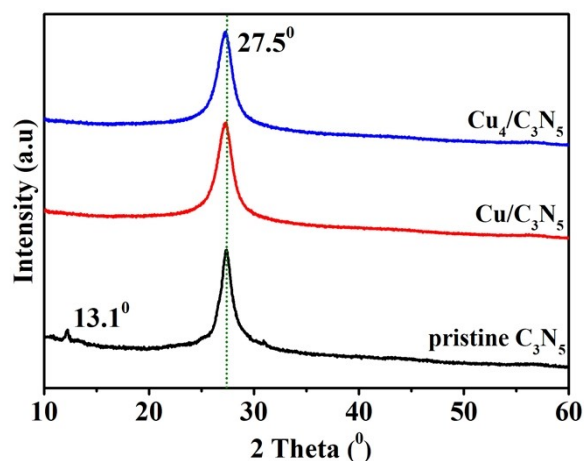


Fig. S1 XRD patterns of pristine C<sub>3</sub>N<sub>5</sub>, Cu/C<sub>3</sub>N<sub>5</sub>, and Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub>.

### Additional discussions

The electrochemical treatment process did not change the structure of C<sub>3</sub>N<sub>5</sub>, as proved by the similar XRD patterns between pristine C<sub>3</sub>N<sub>5</sub> and Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> (Fig. S1). The diffraction peaks at 13.1 and 27.5° could be indexed to (100) and (002) planes of graphitic-C<sub>3</sub>N<sub>5</sub>, respectively.<sup>1,2</sup> Compared to pristine C<sub>3</sub>N<sub>5</sub>, the (002) diffraction peaks of Cu/C<sub>3</sub>N<sub>5</sub> and Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> shifted slightly to lower 2θ angle for the strong interaction between Cu single atoms and C<sub>3</sub>N<sub>5</sub> support. However, the related anchoring of Cu single-atom or Cu<sub>4</sub> clusters would inevitably promote the further distortion in the graphitic-C<sub>3</sub>N<sub>5</sub> framework, resulting in the disappearance (100) planes at 13.1°.

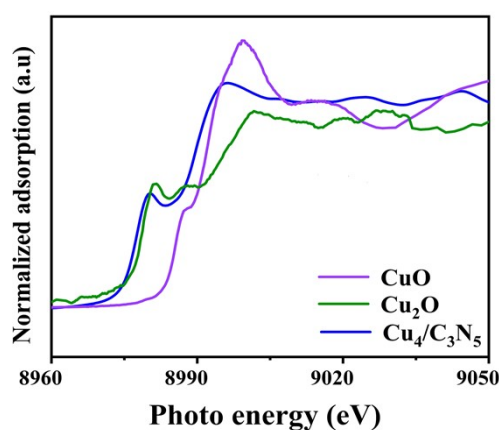
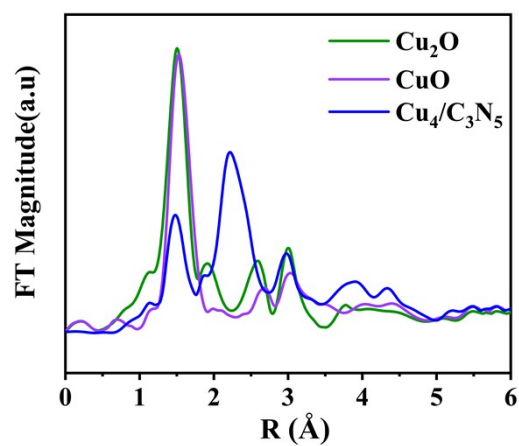
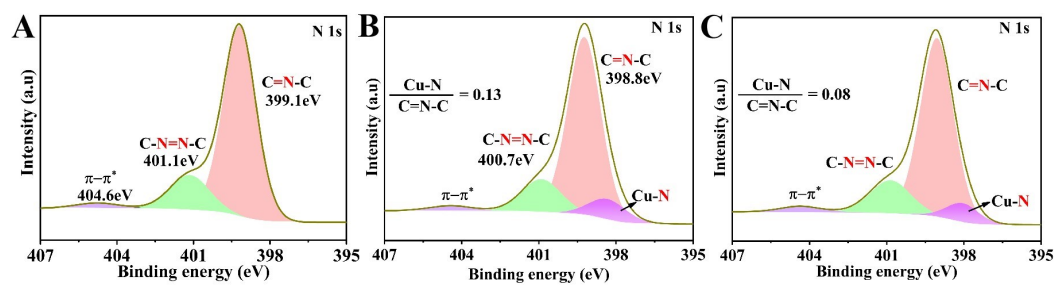


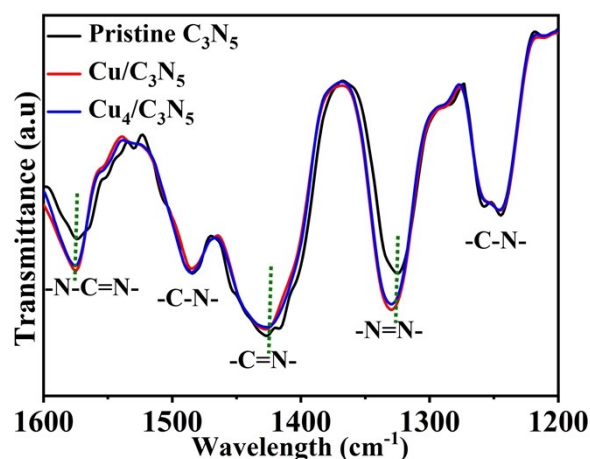
Fig. S2 Cu K-edge XANES spectra of Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> compared with CuO and Cu<sub>2</sub>O.



**Fig. S3** R-space of EXAFS spectra of  $\text{Cu}_4/\text{C}_3\text{N}_5$  compared with  $\text{CuO}$  and  $\text{Cu}_2\text{O}$ .



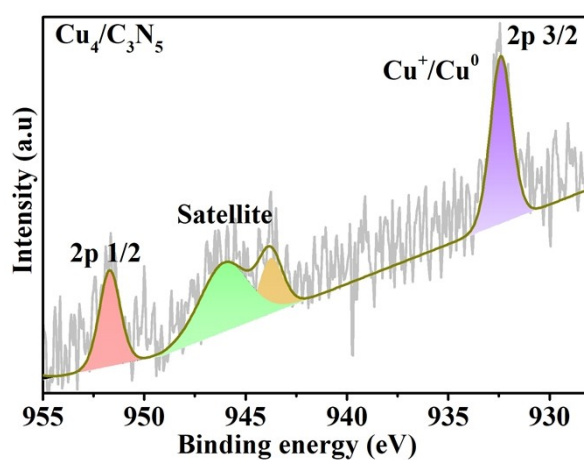
**Fig. S4** The N 1s XPS of pristine  $\text{C}_3\text{N}_5$  (A),  $\text{Cu}/\text{C}_3\text{N}_5$  (B), and  $\text{Cu}_4/\text{C}_3\text{N}_5$  (C).



**Fig. S5** The FTIR spectra of sample pristine  $C_3N_5$ ,  $Cu/C_3N_5$ , and  $Cu_4/C_3N_5$ .

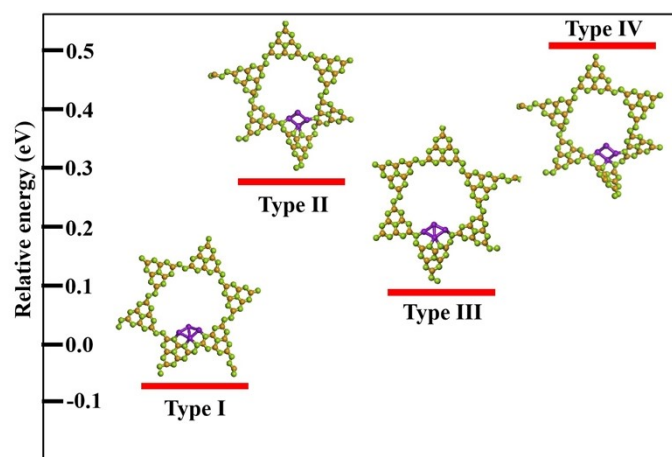
Additional discussions

As seen in N 1s XPS of pristine  $C_3N_5$  (Fig. S4A), the two peaks at 399.1 and 401.1 eV were ascribed to the N atoms of secondary C=N-C and bridging C-N=N-C, respectively.<sup>2</sup> While in  $Cu_4/C_3N_5$ , both peaks shifted to 398.8 and 400.7 eV, respectively (Fig. S4C), suggesting the disturbed chemical- and electronic- environment of N atoms in C=N-C and C-N=N-C moiety. Furthermore, an additional deconvoluted peak at 398.6 eV appeared, which can be ascribed to Cu-N bonds.<sup>3</sup> The strong interaction between Cu atoms and  $C_3N_5$  support was confirmed by the result of FTIR, in which the wavenumbers of N-C=N-, -C=N-, and -N=N- bonds in  $Cu_4/C_3N_5$  all changed in comparison of these in pristine  $C_3N_5$  (Fig. S5).<sup>4</sup> The similar changes were also detected in  $Cu/C_3N_5$  sample.

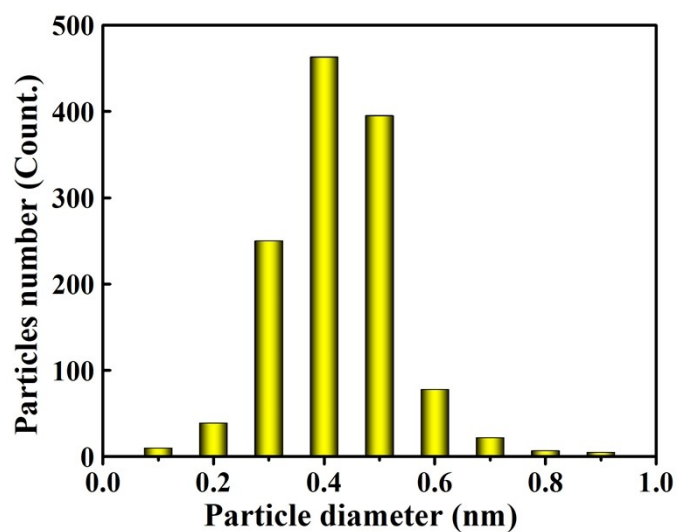


**Fig. S6** The Cu 2p XPS spectrum of  $Cu_4/C_3N_5$ .

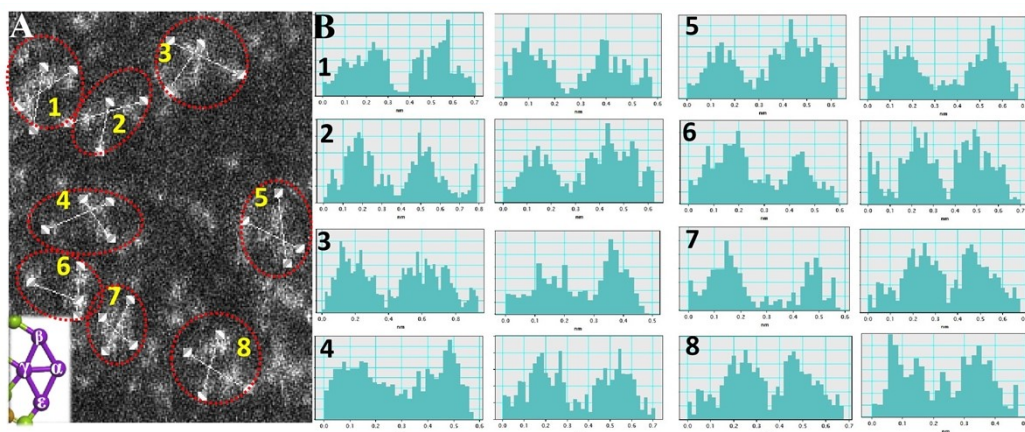




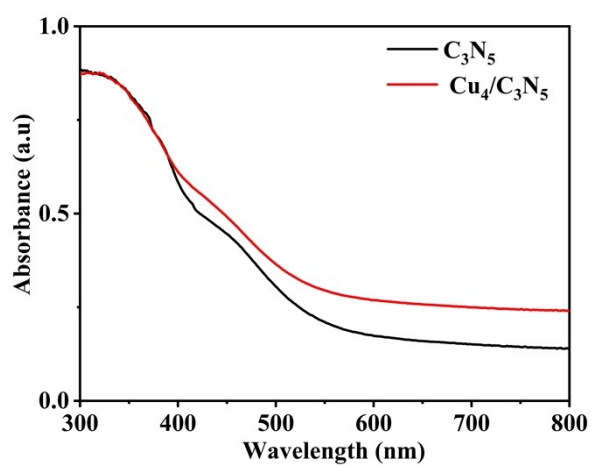
**Fig. S7** Views showing the four types of  $\text{Cu}_4$  clusters combined with  $\text{C}_3\text{N}_5$ .



**Fig. S8** The size distribution of  $\text{Cu}_4$  clusters in  $\text{Cu}_4/\text{C}_3\text{N}_5$ .



**Fig. S9** (A) The aberration-corrected HAADF-STEM image of  $\text{Cu}_4/\text{C}_3\text{N}_5$  with  $\text{Cu}_4$  clusters marked with dashed circles. (B) The image intensity line profiles, which were taken along the solid lines in Fig. S7A.



**Fig. S10** UV-vis DRS of  $\text{Cu}_4/\text{C}_3\text{N}_5$ .

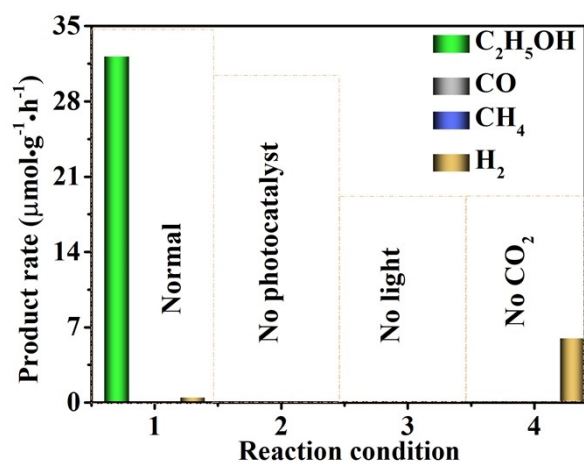


Fig. S11 CO<sub>2</sub> photoreduction results on Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> with different control conditions.

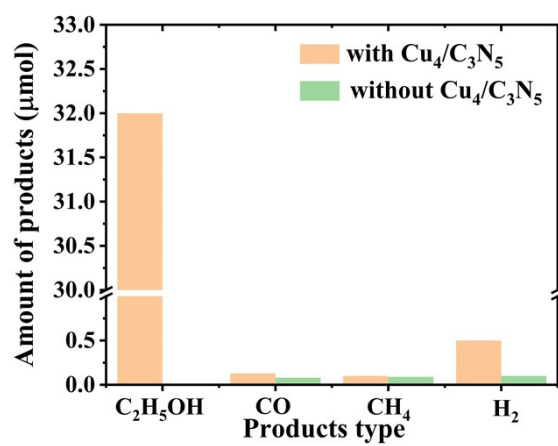
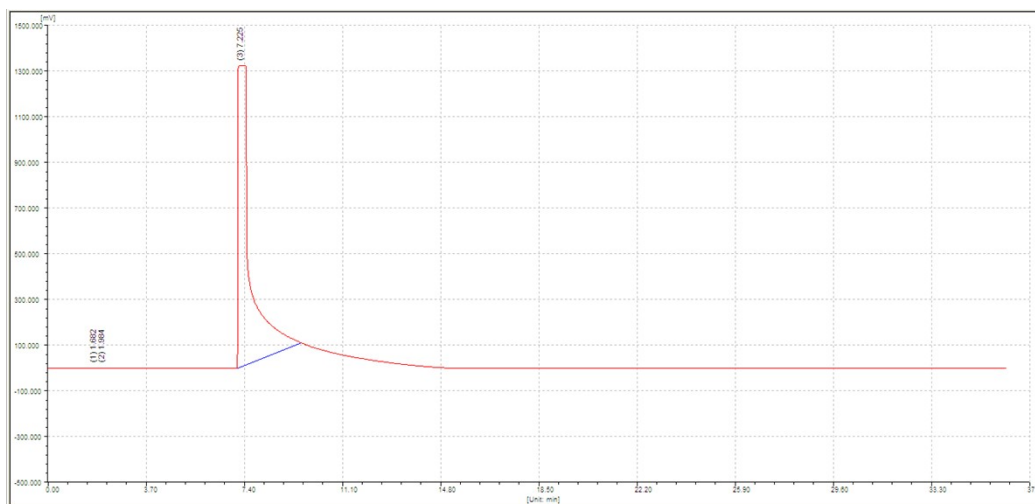
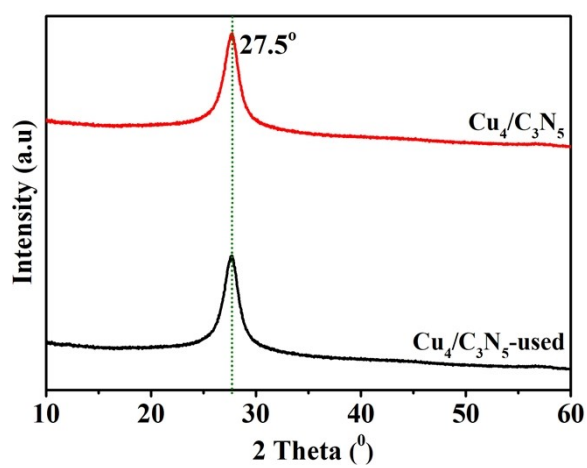


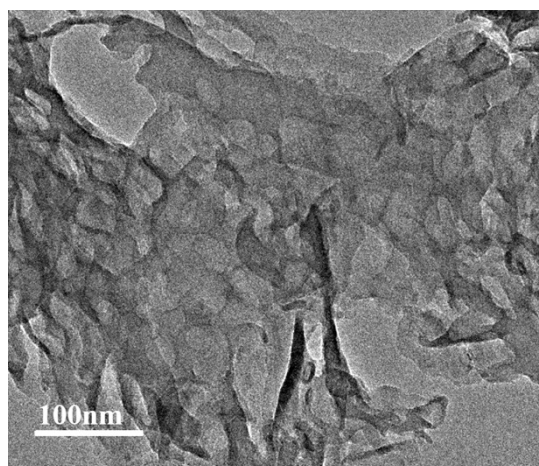
Fig. S12 The comparative photocatalytic experiment results with and without Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> addition



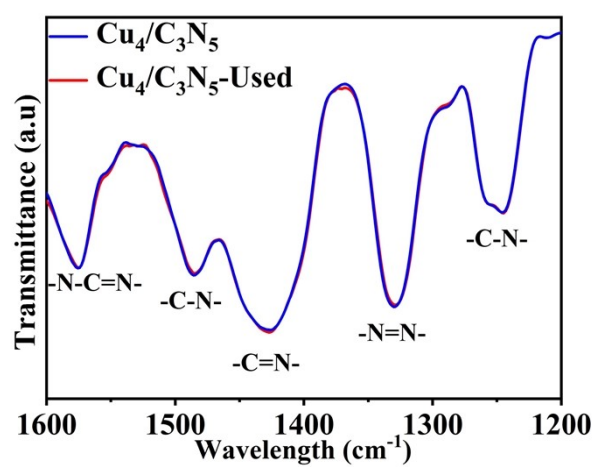
**Fig. S13** The GC test result of  $\text{Cu}_4/\text{C}_3\text{N}_5$  with light and  $\text{CO}_2$  (FID detector).



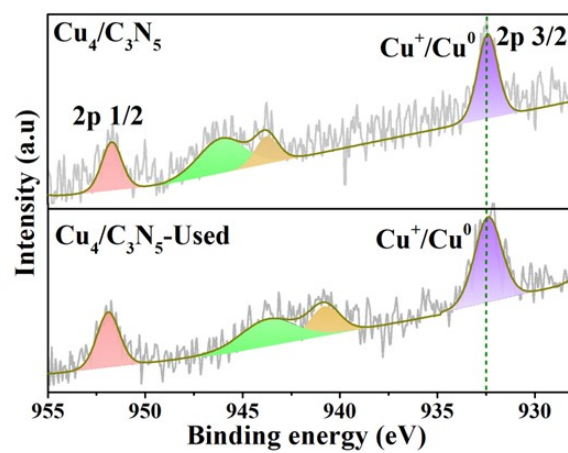
**Fig. S14** The XRD patterns of  $\text{Cu}_4/\text{C}_3\text{N}_5$  before and after photoreaction.



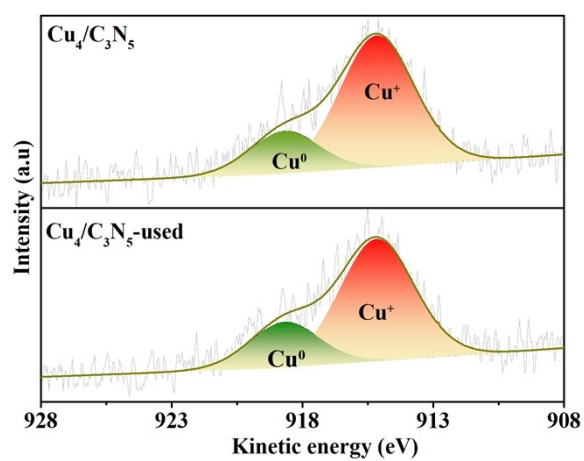
**Fig. S15** The TEM image of Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> after photoreaction.



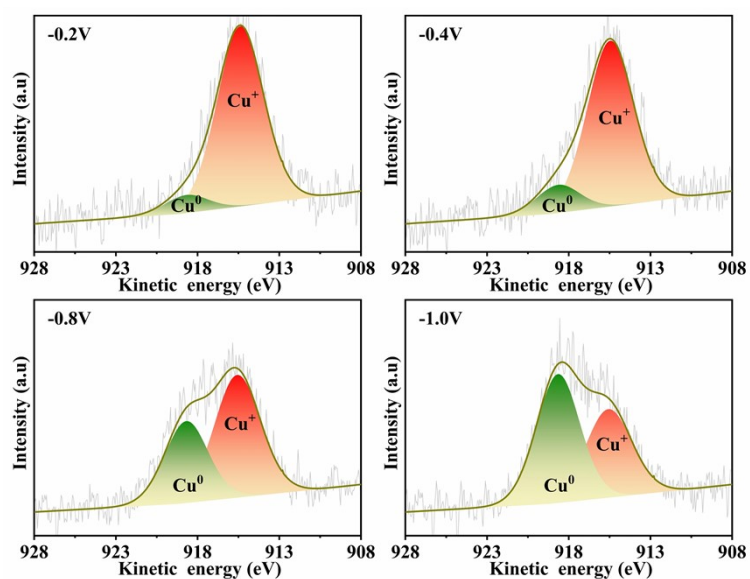
**Fig. S16** The FTIR spectra of Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> before and after photoreaction.



**Fig. S17** The Cu 2p XPS spectra of  $\text{Cu}_4/\text{C}_3\text{N}_5$  before and after photoreaction.



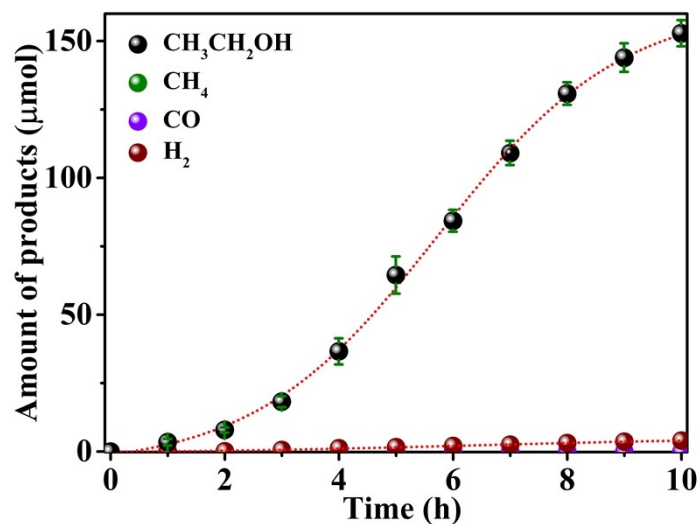
**Fig. S18** The Cu LLM spectra of  $\text{Cu}_4/\text{C}_3\text{N}_5$  before and after photoreaction.



**Fig. S19** Cu LLM Auger spectra of the samples obtained under different applied bias.

Additional discussions

The  $\text{Cu}^+/\text{Cu}^0$  ratio was potential-dependent. The calculated  $\text{Cu}^+/\text{Cu}^0$  ratios were 11.12, 6.03, 1.53, and 0.73 for the samples obtained at applied potential of -0.2, -0.4, -0.8, and -1.0 V vs RHE, respectively (Fig. S19).<sup>5</sup>



**Fig. S20** Time course of  $\text{CO}_2$  amount on  $\text{Cu}_4/\text{C}_3\text{N}_5$  with the TEOA addition.

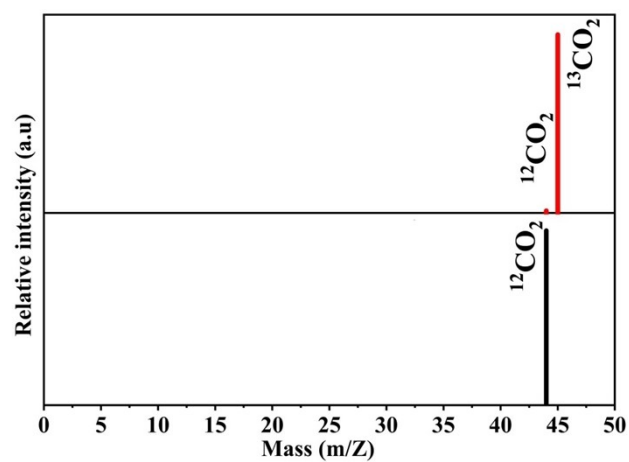


Fig. S21 MS spectra of  $^{13}\text{CO}_2$  and  $^{12}\text{CO}_2$ .

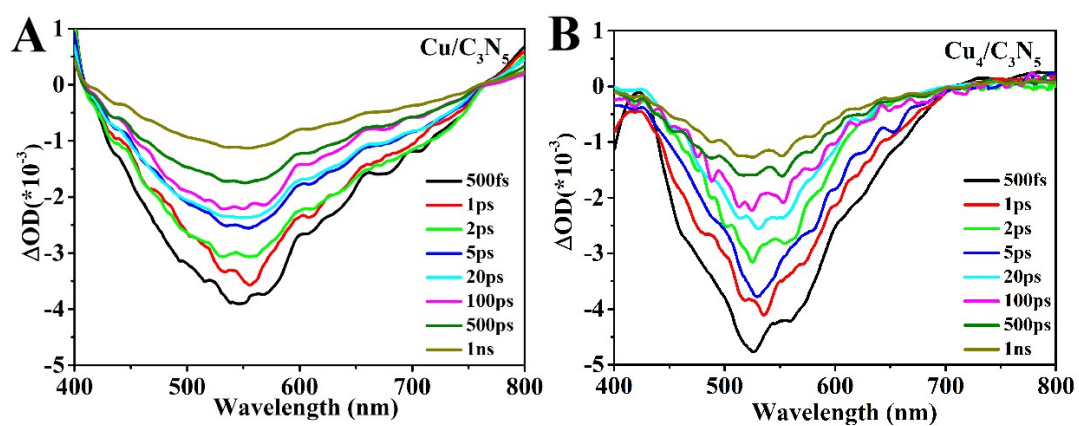


Fig. S22 Femtosecond pump-probe transient absorption spectra of  $\text{Cu}_4/\text{C}_3\text{N}_5$  (A) and  $\text{Cu}/\text{C}_3\text{N}_5$  (B) systems.



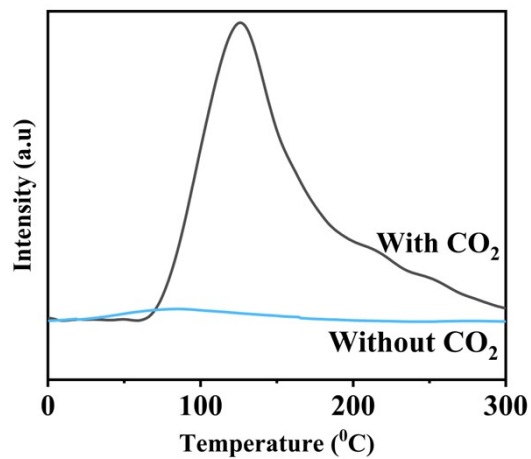


Fig. S23 TPD curves of Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> with and without CO<sub>2</sub> gas.

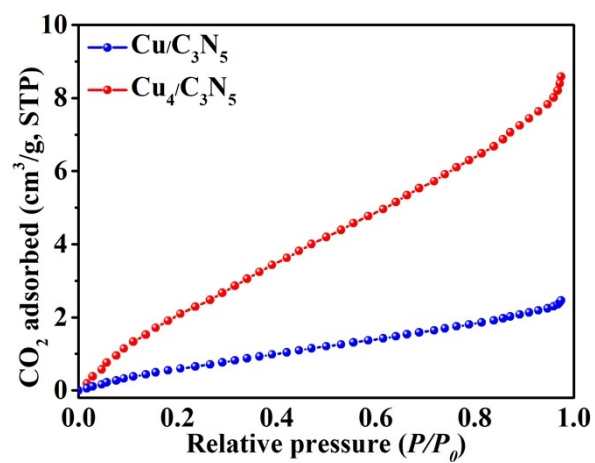


Fig. S24 CO<sub>2</sub> adsorption isotherm curves of Cu/C<sub>3</sub>N<sub>5</sub> and Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub>.

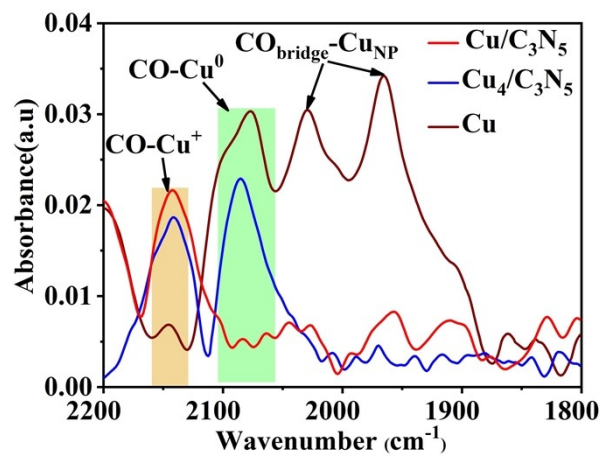


Fig. S25 The CO adsorption curves on Cu/C<sub>3</sub>N<sub>5</sub> and Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub>.

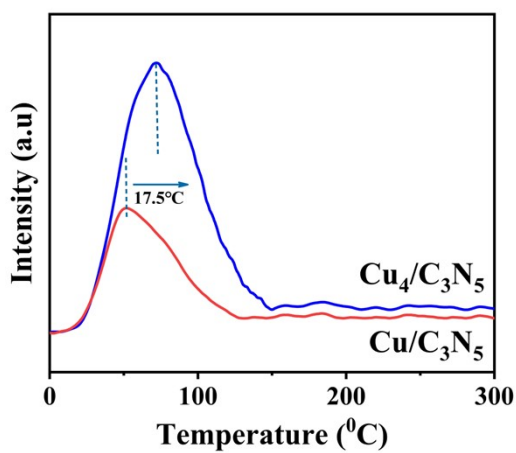
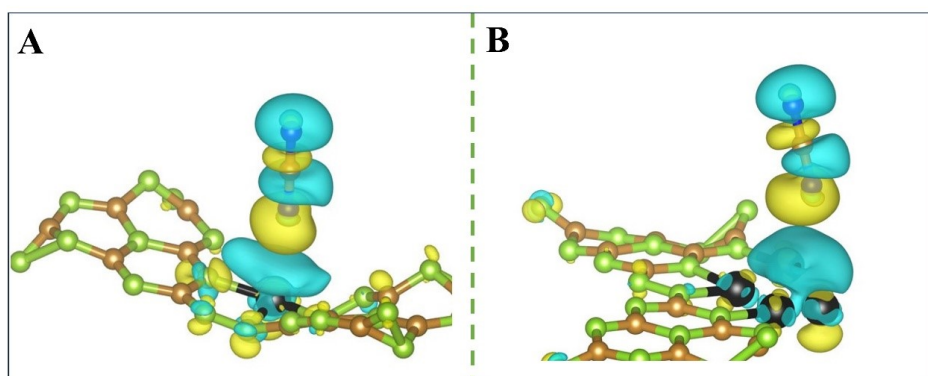
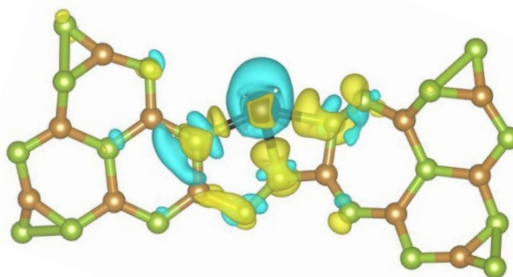


Fig. S26 CO-TPD spectra of Cu/C<sub>3</sub>N<sub>5</sub> and Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub>.



**Fig. S27** Differential charge density calculations for Cu/C<sub>3</sub>N<sub>5</sub> (A) and Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> (B) with CO<sub>2</sub> adsorption.



**Fig. S28** Differential charge density calculations for Cu<sup>δ+</sup> over Cu/C<sub>3</sub>N<sub>5</sub>.

#### **Additional discussions**

The charge concentration of Cu<sup>+</sup> atom was further reduced owing to the coordinated N atoms. Because of the asymmetrical electronic structure of Cu<sub>4</sub> clusters, when CO<sub>2</sub> adsorption, the electrons flowed from Cu atoms to adsorbed CO<sub>2</sub> molecules (Fig. S27), resulting in the higher CO<sub>2</sub> adsorption energy of Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub> than Cu/C<sub>3</sub>N<sub>5</sub> (without asymmetrical electronic structure, Fig. S28). It was beneficial for the activation of CO<sub>2</sub>.

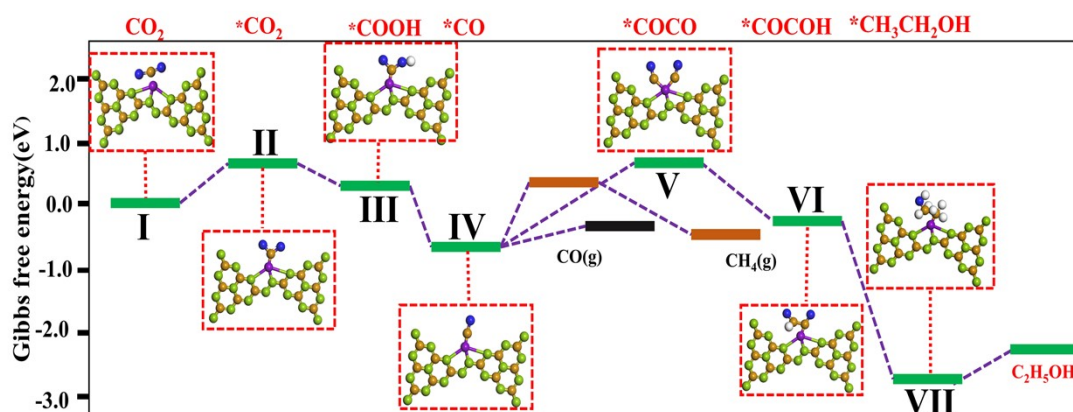


Fig. S29 Gibbs free energy diagrams and CO<sub>2</sub> to ethanol photoreduction pathways on Cu/C<sub>3</sub>N<sub>5</sub>.

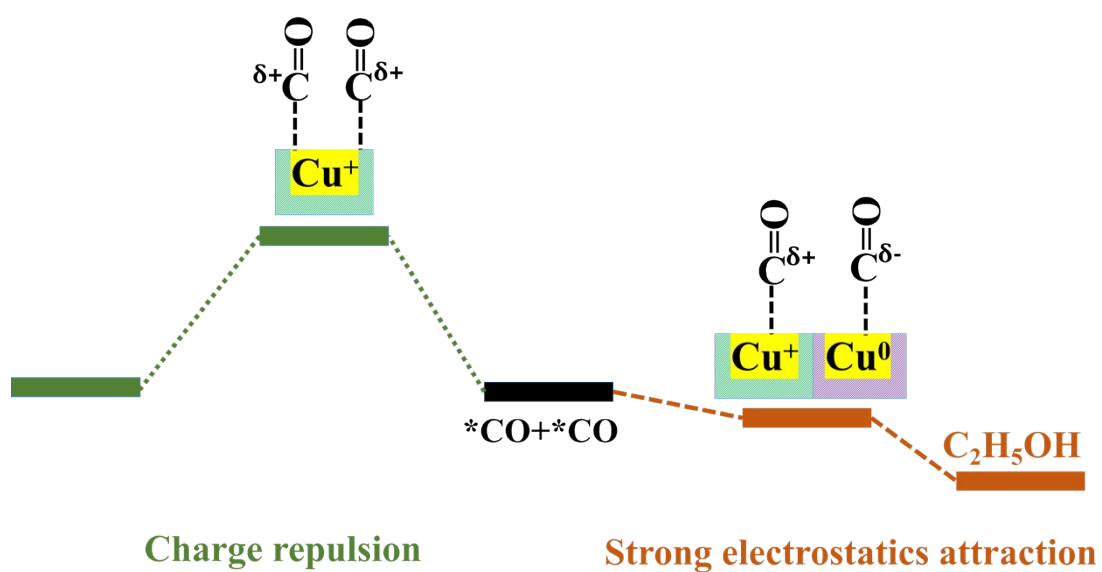


Fig. S30 Free-energy profiles for \*CO dimerization on Cu/C<sub>3</sub>N<sub>5</sub> and Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub>.

## Additional Tables

**Table S1** Structural parameters obtained from Cu K-edge EXAFS fitting.

Sample	Coordination	CN	R(Å)	$\sigma^2 \times 10^{-3}(\text{Å}^2)$	$\Delta E_0(\text{eV})$	R-factor
Cu foil	Cu-Cu	12	2.53±0.03	9.0±1.5	2.3	0.002
Cu <sub>2</sub> O	Cu-O	4	1.84±0.02	3.1±0.4	8.3	0.006
CuO	Cu-O	4	1.94±0.02	3.6±0.9	0.2	0.004
Cu/C <sub>3</sub> N <sub>5</sub>	Cu-N	3.3±0.5	1.92±0.02	7.6±1.6	2.7	0.001
Cu <sub>4</sub> /C <sub>3</sub> N <sub>5</sub>	Cu-N	2.2±0.5	1.91±0.04	8.9±2.1	2.3	0.002
	Cu-Cu	2.6±0.6	2.51±0.03	9.6±1.7	2.3	0.002

CN: Coordination number.

**Table S2** Comparison of photocatalytic performance in CO<sub>2</sub> reduction to ethanol

Photocatalyst	Metal loading (wt.%)	Light source	Medium	Rate ( $\mu\text{mol g}^{-1}\text{h}^{-1}$ )	Sel.(%)	Refs
Cu <sub>4</sub> /C <sub>3</sub> N <sub>5</sub>	2.65	300 W Xe ( $\lambda \geq 420\text{nm}$ )	H <sub>2</sub> O	32.2	98.6	This work
Cu <sub>4</sub> /C <sub>3</sub> N <sub>5</sub>	2.65	300 W Xe ( $\lambda \geq 420\text{nm}$ )	TEOA/H <sub>2</sub> O	152.8	97.7	This work
BP/BWO	N.R	300 W Xe	H <sub>2</sub> O	3.8	32.2	Ref <sup>7</sup>
BP/BWO	N.R	300 W Xe	Benzylamine/H <sub>2</sub> O	61.3	91.0	Ref <sup>7</sup>
Oxide-derived Cu/PCN	0.65	300 W Xe	TEOA/H <sub>2</sub> O	2.8	58.0	Ref <sup>8</sup>
C <sub>3</sub> N <sub>4</sub> /UiO-66(Zr/Ce)	N.R	300 W Xe	Acetonitrile/H <sub>2</sub> O	38.1	41.1	Ref <sup>9</sup>
InCu/PCN	In: 1.0; Cu: 0.5	300 W Xe	DMF/H <sub>2</sub> O	28.5	92.4	Ref <sup>10</sup>
Cu/PCN	Cu: 0.5	300 W Xe	DMF/H <sub>2</sub> O	11.8	89.6	Ref <sup>10</sup>
STO/Cu@Ni/TiN	N.R	300 W Xe	H <sub>2</sub> O	21.3	79.0	Ref <sup>11</sup>
Bi@Bi <sub>2</sub> MoO <sub>6</sub>	N.R	300 W Xe ( $\lambda \geq 400\text{ nm}$ )	NaHCO <sub>3</sub>	17.93	92.0	Ref <sup>12</sup>
TiO <sub>2</sub> {100}	N.R	300 W UV enhanced Xe	NaHCO <sub>3</sub>	6.16	66.7	Ref <sup>13</sup>
Cu <sub>SAs</sub> /UiO-66-NH <sub>2</sub>	0.39%	300 W Xe	TEOA/H <sub>2</sub> O	4.22	54.3	Ref <sup>14</sup>
Cu-(Ni,Zr)-UiO-66-NH	Cu: 0.2; Ni: 0.2	300 W Xe ( $\lambda \geq 420\text{nm}$ )	TEOA/H <sub>2</sub> O	7.08	97.3%	Ref <sup>15</sup>

N.R: not reported.

**Table S3** Exponential fitting parameters for the Fluorescence of Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub>

Samples	A <sub>1</sub>	τ <sub>1</sub> (ns)	A <sub>2</sub>	τ <sub>2</sub> (ns)	A <sub>3</sub>	τ <sub>3</sub> (ns)	τ <sub>avg</sub> (ns)	R <sup>2</sup>
Cu/C <sub>3</sub> N <sub>5</sub>	0.31	6.11	0.34	2.79	0.35	6.02	5.12	0.998
Cu <sub>4</sub> /C <sub>3</sub> N <sub>5</sub>	0.34	7.13	0.26	3.11	0.40	11.18	9.05	0.998

**Table S4** Exponential fitting parameters for fs-TA of Cu<sub>4</sub>/C<sub>3</sub>N<sub>5</sub>

Samples	A <sub>1</sub>	τ <sub>1</sub> (ps)	A <sub>2</sub>	τ <sub>2</sub> (ps)	A <sub>3</sub>	τ <sub>3</sub> (ps)	τ <sub>avg</sub> (ps)	R <sup>2</sup>
Cu/C <sub>3</sub> N <sub>5</sub>	0.40	2.11	0.31	28.15	0.29	1249.90	314.1	0.997
Cu <sub>4</sub> /C <sub>3</sub> N <sub>5</sub>	0.51	1.49	0.26	20.41	0.21	945.16	223.6	0.996

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